

**Search Notes**

Application/Control No.

10/825,594

Examiner

Tai Duong

Applicant(s)/Patent under  
Reexamination

LEE, YUN-BOK

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	14	11/27/2006	TD
	38		
	39		
	43		
	110		
	146		
	187		
257	59		
	72		
345	92		
438	30		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US PG PUB; US PAT; FPRS; EPO; JPO; DERWENT; IBM TDB) see search history printout	11/27/2006	TD